Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/736,720	LEE, KEUN WOO
Examiner	Art Unit
Eric B. Chen	1765

Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	<u>. </u>				
PB-PUB text search		12/3/2005	EC		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventor search (UPDATED)	12/3/2005	EC
EAST (all databases) (UPDATED) - see search history printout	12/3/2005	EC
438/221,296,427,637,369,370,690- 692,700,702,706,710,719,723,724, 745,753,756,757,770,775 (text search only) (UPDATED)	12/3/2005	EC